

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Peter de Groot et al.  
Serial No. : 10/795,808  
Filed : March 8, 2004  
Title : PROFILING COMPLEX SURFACE STRUCTURES USING SCANNING  
INTERFEROMETRY

Art Unit : 2877  
Examiner : Unknown

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050. referencing Attorney Docket No. 09712-341001.

Respectfully submitted,

Date:

8/26/04

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\*See attached document certifying that Marc M. Wefers has limited recognition to practice before the U.S. Patent and Trademark Office under 37 C.F.R. § 10.9(b).

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CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

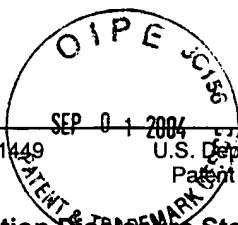
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Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	Attorney's Docket No. <b>09712-341001</b>	Application No. <b>10/795,808</b>
	Applicant <b>Peter de Groot et al.</b>	
	Filing Date <b>March 8, 2004</b>	Group Art Unit <b>2877</b>

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,398,113	03/14/1995	de Groot	356	360	
	AB	5,587,792	12/24/1996	Nishizawa et al.	355	356	
	AC	5,900,633	05/04/1999	Solomon et al.	250	339.08	
	AD	6,242,739	06/05/2001	Cherkassky	250	339.11	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	0 929 094 A2	07/14/1999	EPO	H01L	21/00		
	AM							
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	